# 2SD2137, 2SD2137A

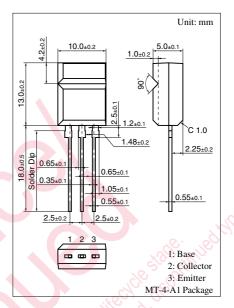
## Silicon NPN triple diffusion planar type

For power amplification
Complementary to 2SB1417 and 2SB1417A

#### ■ Features

- ullet High forward current transfer ratio  $h_{FE}$  which has satisfactory linearity
- $\bullet$  Low collector to emitter saturation voltage  $V_{\text{CE(sat)}}$
- Allowing supply with the radial taping
- Absolute Maximum Ratings  $T_C = 25$ °C

Paramet	er	Symbol	Rating	Unit
Collector to base	2SD2137	$V_{CBO}$	60	V
voltage	2SD2137A		80	
Collector to	2SD2137	V <sub>CEO</sub>	60	v
emitter voltage	2SD2137A		80	
Emitter to base voltage		V <sub>EBO</sub>	6	v
Peak collector current		$I_{CP}$	5	A
Collector current		$I_{C}$	3	A
Collector power	$T_C = 25^{\circ}C$	P <sub>C</sub>	15	W
dissipation	$T_a = 25^{\circ}C$		2	
Junction temperature		T <sub>j</sub>	150	°C
Storage temperatu	re	T <sub>stg</sub>	-55 to +150	°C



### ■ Electrical Characteristics $T_C = 25$ °C

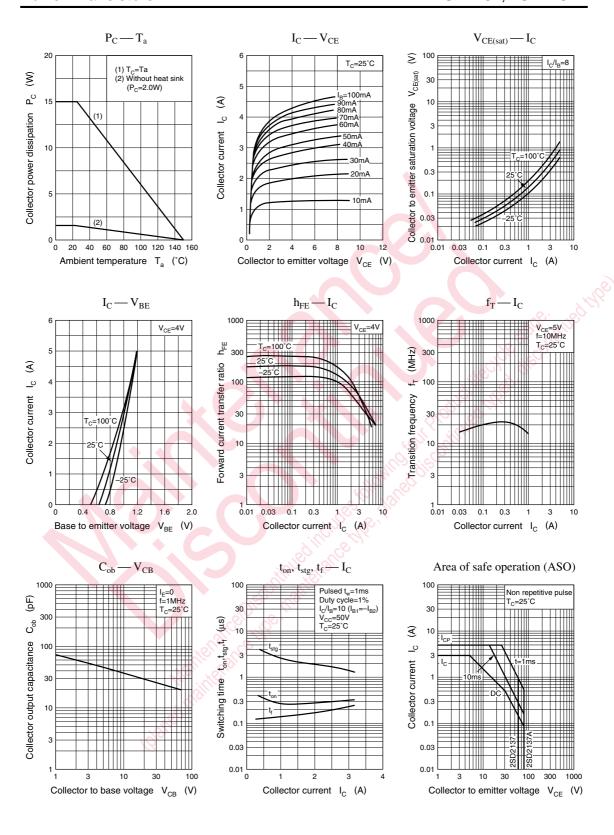
Parameter	r	Symbol	Conditions	Min	Тур	Max	Unit
Collector cutoff	2SD2137	I <sub>CES</sub>	$V_{CE} = 60 \text{ V}, V_{BE} = 0$			100	μΑ
current	2SD2137A		$V_{CE} = 80 \text{ V}, V_{BE} = 0$			100	
Collector cutoff	2SD2137	I <sub>CEO</sub>	$V_{CE} = 30 \text{ V}, I_{B} = 0$			100	μΑ
current	2SD2137A		$V_{CE} = 60 \text{ V}, I_{B} = 0$			100	
Emitter cutoff current		I <sub>EBO</sub>	$V_{EB} = 6 \text{ V}, I_{C} = 0$			100	μΑ
Collector to emitter	2SD2137	V <sub>CEO</sub>	$I_C = 30 \text{ mA}, I_B = 0$	60			V
voltage	2SD2137A	*81/0, VG		80			
Forward current transfe	er ratio	h <sub>FEI</sub> *	$V_{CE} = 4 \text{ V}, I_{C} = 1 \text{ A}$	70		250	
		h <sub>FE2</sub>	$V_{CE} = 4 \text{ V}, I_{C} = 3 \text{ A}$	10			
Base to emitter voltage		$V_{BE}$	$V_{CE} = 4 \text{ V}, I_{C} = 3 \text{ A}$			1.8	V
Collector to emitter satu	ration voltage	V <sub>CE(sat)</sub>	$I_C = 3 A, I_B = 0.375 A$			1.2	V
Transition frequency	10,0	$f_T$	$V_{CE} = 5 \text{ V}, I_{C} = 0.2 \text{ A}, f = 10 \text{ MHz}$		30		MHz
Turn-on time		t <sub>on</sub>	$I_C = 1 A$ , $I_{B1} = 0.1 A$ , $I_{B2} = -0.1 A$ ,		0.3		μs
Storage time		t <sub>stg</sub>	$V_{CC} = 50 \text{ V}$		2.5		μs
Fall time		$t_{\rm f}$			0.2		μs

Note) \*: Rank classification

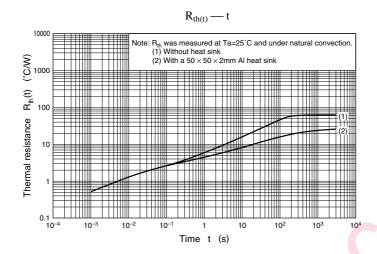
Rank	Q	R
h <sub>FE1</sub>	70 to 150	120 to 250

Ordering can be made by the common rank (PQ rank  $h_{\text{FE}1}$  = 70 to 250) in the rank classification.

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